

Notice of References Cited	Application/Control No. 10/813,408		Applicant(s)/Patent Under Reexamination LEU ET AL.	
	Examiner Adam C. Rehm		Art Unit 2875	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0193796	10-2003	Heeks et al.	362/84
*	B	US-2003/0142487	07-2003	Fan, Kuo-Shu	362/29
*	C	US-6,824,287	11-2004	Moon, Jeong-Min	362/84
*	D	US-6,199,994	03-2001	Watai, Kayoko	362/617
*	E	US-6,120,160	09-2000	Nakagawa, Toshiaki	362/97
*	F	US-5,673,999	10-1997	Koenck, Steven E.	362/263
*	G	US-5,477,422	12-1995	Hooker et al.	362/29
*	H	US-5,057,974	10-1991	Mizobe, Tatsuji	362/26
*	I	US-4,267,489	05-1981	Morohashi, Hisao	315/324
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP07288023	10-1995	Japan	Saski Kenichi	F21V 11/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.